

SBOS278B – SEPTEMBER 2003 – REVISED JANUARY 2004

# Very Low Noise, High-Speed, 12V CMOS Operational Amplifier

## **FEATURES**

- BANDWIDTH: 20MHz
- SLEW RATE: 30V/μs
- FAST 16-BIT SETTLING TIME
- LOW NOISE: 6nV/\/Hz (typ) at 100kHz
- EXCELLENT CMRR, PSRR, and A<sub>OL</sub>
- RAIL-TO-RAIL OUTPUT
- CM RANGE INCLUDES GND
- THD+N: 0.0003% (typ) at 1kHz
- QUIESCENT CURRENT: 5.5mA/ch (max)
- SUPPLY VOLTAGE: 4V to 12V
- SHUTDOWN MODE (OPAx726): 6μA/ch

## APPLICATIONS

- OPTICAL NETWORKING
- TRANSIMPEDANCE AMPLIFIERS
- INTEGRATORS
- ACTIVE FILTERS
- A/D CONVERTER BUFFERS
- I/V CONVERTER FOR DACs
- PORTABLE AUDIO
- PROCESS CONTROL
- TEST EQUIPMENT

#### **OPA725 RELATED PRODUCTS**

FEATURES	PRODUCT
<u>10MHz,</u> 16V, 16V/μs, 8.5nV/√Hz at 1kHz	TLC080
8MHz, 36V, FET Input, 20V/μs, 8.5nV/√Hz at 1kHz	OPA132
100MHz, 5.5V, Precision Transimpedance Amplifier	OPA380
500MHz, ±5V, FET Input, 290V/µs, 7nV/√Hz at 100kHz	OPA656
7MHz, 12V, RRIO, 10V/µs, 30nV/√Hz at 10kHz	OPA743
16-Bit, 250kSPS, 4-Channel, Parallel Output ADC	ADS8342

-12V

**OPA726** 

Enable

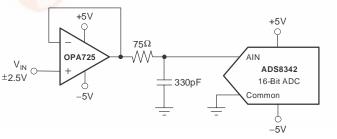
## DESCRIPTION

The OPA725 and OPA726 series op amps use a state-of-the-art 12V analog CMOS process, and combine outstanding ac performance with low bias current and excellent CMRR, PSRR, and  $A_{OL}$ . The 20MHz Gain-Bandwidth (GBW) Product is achieved by using a proprietary and patent-pending output stage design. These characteristics allow excellent 16-bit settling times for driving 16-bit Analog-to-Digital converters (ADCs).

Excellent ac characteristics, such as 20MHz GBW, 30V/µs slew rate and 0.0003% THD+N make the OPA725 and OPA726 well-suited for communication, high-end audio, and active filter applications. With a bias current of less than 200pA, they are well-suited for use as transimpedance (I/V-conversion) amplifiers for monitoring optical power in ONET applications.

The OPA725 and OPA726 op amps can be used in single-supply applications from 4V up to 12V, or dual-supply from  $\pm 2V$  to  $\pm 6V$ . The output swings to within 150mV of the rails, maximizing dynamic range. The shutdown versions (OPAx726) reduce the quiescent current to less than 6µA and feature a reference pin for easy shutdown operation with standard CMOS logic in dual-supply applications.

The OPA725 (single) is available in SOT23-5 and SO-8 packages, and the OPA2725 (dual) is available in MSOP-8 and SO-8 packages. The OPA726 (single with shutdown) is available in MSOP-8 and SO-8. The OPA2726 (dual with shutdown) is available in MSOP-10. All versions are specified for operation from  $-40^{\circ}$ C to  $+125^{\circ}$ C.



PDPlease be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments

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#### **ORDERING INFORMATION**

PRODUCT	PACKAGE-LEAD	PACKAGE DESIGNATOR <sup>(1)</sup>	SPECIFIED TEMPERATURE RANGE	PACKAGE MARKING	ORDERING NUMBER	TRANSPORT MEDIA, QUANTITY
Non-Shutdown						
OPA725 ″ OPA725 ″	SOT23-5 ″ SO-8 ″	DBV ″ D	-40°C to +125°C ″ -40°C to +125°C ″	OALI ″ OPA725A ″	OPA725AIDBVT OPA725AIDBVR OPA725AID OPA725AIDR	Tape and Reel, 250 Tape and Reel, 3000 Rails, 100 Tape and Reel, 2500
OPA2725 ″ OPA2725 ″	SO-8 ″ MSOP-8 ″	D ″ DGK	-40°C to +125°C ″ -40°C to +125°C ″	OPA2725A ″ BGM ″	OPA2725AID OPA2725AIDR OPA2725AIDGKT OPA2725AIDGKR	Rails, 100 Tape and Reel, 2500 Tape and Reel, 250 Tape and Reel, 2500
Shutdown						
OPA726 ″ OPA726 ″	SO-8 ″ MSOP-8 ″	D ″ DGK	-40°C to +125°C ″ -40°C to +125°C ″	OPA726A ″ BHC ″	OPA726AID OPA726AIDR OPA726AIDGKT OPA726AIDGKR	Rails, 100 Tape and Reel, 2500 Tape and Reel, 250 Tape and Reel, 2500
OPA2726 ″	MSOP-10 ″	DGS ″	–40°C to +125°C ″	BHB ″	OPA2726AIDGST OPA2726AIDGSR	Tape and Reel, 250 Tape and Reel, 2500

(1) For the most current package and ordering information, see the Package Option Addendum located at the end of this datasheet.



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

Supply Voltage	+13.2V
Signal Input Terminals, Voltage <sup>(2)</sup>	-0.5V to (V+) + 0.5V
Current <sup>(2)</sup>	±10mA
Output Short Circuit <sup>(3)</sup>	Continuous
Operating Temperature	–55°C to +125°C
Storage Termperature	–55°C to +150°C
Junction Temperature	+150°C
Lead Temperature (soldering, 10s)	+300°C
ESD Rating (Human Body Model)	1000 V

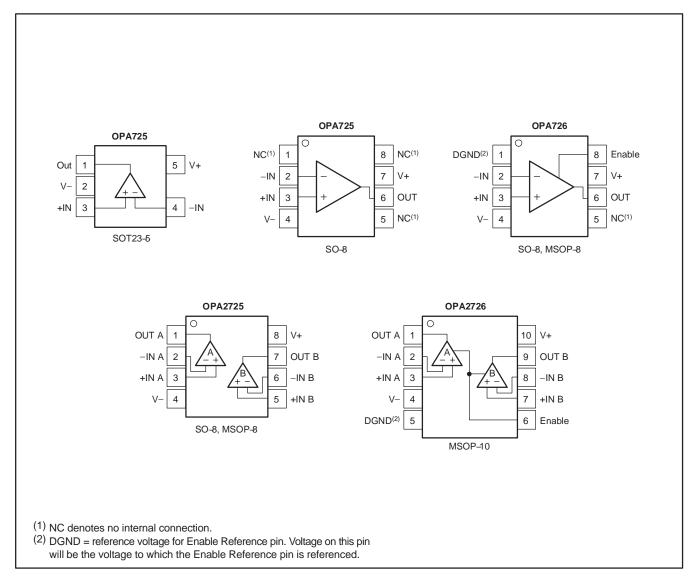
(1) Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not supported.

- (2) Input terminals are diode-clamped to the power-supply rails. Input signals that can swing more than 0.5V beyond the supply rails should be current limited to 10mA or less.
- (3) Short-circuit to ground, one amplifier per package.



SBOS278B - SEPTEMBER 2003 - REVISED JANUARY 2004

#### **PIN CONFIGURATIONS**





SBOS278B - SEPTEMBER 2003 - REVISED JANUARY 2004

# ELECTRICAL CHARACTERISTICS: $V_S = +4V$ to +12V or $V_S = \pm 2V$ to $\pm 6V$ Boldface limits apply over the specified temperature range, $T_A = -40$ °C to +125°C.

At  $T_A = +25^{\circ}$ C,  $R_L = 10$ k $\Omega$  connected to V<sub>S</sub>/2, and V<sub>OUT</sub> = V<sub>S</sub>/2, unless otherwise noted.

			OPA725, OPA726, OPA2725, OPA2726			
PARAMETER		CONDITIONS	MIN	TYP	MAX	UNIT
OFFSET VOLTAGE						1
Input Offset Voltage	Vos					
OPA725, OPA726		$V_{S} = \pm 6V, V_{CM} = 0V$		1.2	3	mV
OPA2725, OPA2726		$V_{S} = \pm 6V, V_{CM} = 0V$		1.5	5	mV
Drift	dV <sub>OS</sub> /dT			4		μ <b>V/</b> ° <b>C</b>
vs Power Supply	PSRR	$V_S = \pm 2V$ to $\pm 6V$ , $V_{CM} = V -$		30	100	μV/V
Over Temperature		$V_S = \pm 2V$ to $\pm 6V$ , $V_{CM} = V -$			150	μ <b>V/V</b>
Channel Separation, DC				1		μV/V
INPUT BIAS CURRENT						
Input Bias Current	IB			30	200	pА
Over Temperature			See Ty	pical Charact	teristics	
Input Offset Current	I <sub>OS</sub>			10	50	pА
NOISE						
Input Voltage Noise, $f = 0.1Hz$ to $10Hz$	e <sub>n</sub>	$V_S = \pm 6V, V_{CM} = 0V$		10		μV <sub>PP</sub>
Input Voltage Noise Density, f = 10kHz	en	$V_{S} = \pm 6V, V_{CM} = 0V$		10		nV/√Hz
Input Voltage Noise Density, f = 100kHz	en	$V_{S} = \pm 6V, V_{CM} = 0V$		6		nV/√Hz
Input Current Noise Density, f = 1kHz	i <sub>n</sub>	$V_S = \pm 6V, V_{CM} = 0V$		2.5		fA/√Hz
INPUT VOLTAGE RANGE						
Common-Mode Voltage Range	V <sub>CM</sub>		(V–)		(V+) – 2	V
Common-Mode Rejection Ratio	CMRR	$(V-) \le V_{CM} \le (V+) - 2V$	88	94		dB
Over Temperature		(V–) ≤ V <sub>CM</sub> ≤ (V+) – 2V	84			dB
		$(V-) \le V_{CM} \le (V+) - 3V$	94	100		dB
Over Temperature		$(V-) \leq V_{CM} \leq (V+) - 3V$	84			dB
INPUT IMPEDANCE						
Differential				10 <sup>11</sup>   5		Ω  pF
Common-Mode				10 <sup>11</sup>   4		Ω  pF
OPEN-LOOP GAIN						
Open-Loop Voltage Gain	AOL					
OPA725, OPA726		$R_L = 100 k\Omega$ , 0.15V < V <sub>O</sub> < (V+) – 0.15V	110	120		dB
Over Temperature		R <sub>L</sub> = 100kΩ, 0.15V < V <sub>O</sub> < (V+) – 0.15V	100			dB
OPA2725, OPA2726		$R_L = 100 k\Omega$ , 0.175V < $V_O$ < (V+) – 0.175V	110	120		dB
Over Temperature		$R_L$ = 100kΩ, 0.175V < V <sub>O</sub> < (V+) – 0.175V	100			dB
OPA725, OPA726		$R_L = 1k\Omega$ , $0.25V < V_O < (V+) - 0.25V$	106	116		dB
Over Temperature		$R_L$ = 1kΩ, 0.25V < V <sub>O</sub> < (V+) – 0.25V	96			dB
OPA2725, OPA2726		$R_L = 2k\Omega$ , 0.25V < $V_O$ < (V+) – 0.25V	106	116		dB
Over Temperature		$R_L = 2k\Omega$ , 0.25V < $V_O$ < (V+) – 0.25V	96			dB
FREQUENCY RESPONSE		$C_L = 20 pF$				
Gain-Bandwidth Product	GBW			20		MHz
Slew Rate	SR	G = +1		30		V/µs
Settling Time, 0.1%	ts	$V_S = \pm 6V$ , 5V Step, G = +1		350		ns
0.01%		$V_S = \pm 6V$ , 5V Step, G = +1		450		ns
Overload Recovery Time		V <sub>IN</sub> ● Gain > V <sub>S</sub>		50		ns
Total Harmonic Distortion + Noise	THD+N	$V_{S} = \pm 6V$ , $V_{OUT} = 2V_{RMS}$ , $R_{L} = 600\Omega$ , G = +1, f = 1kHz		0.0003		%



SBOS278B - SEPTEMBER 2003 - REVISED JANUARY 2004

# ELECTRICAL CHARACTERISTICS: $V_S = +4V$ to +12V or $V_S = \pm 2V$ to $\pm 6V$ (continued) Boldface limits apply over the specified temperature range, $T_A = -40^{\circ}C$ to $+125^{\circ}C$ .

At  $T_A = +25^{\circ}C$ ,  $R_L = 10k\Omega$  connected to  $V_S/2$ , and  $V_{OUT} = V_S/2$ , unless otherwise noted.

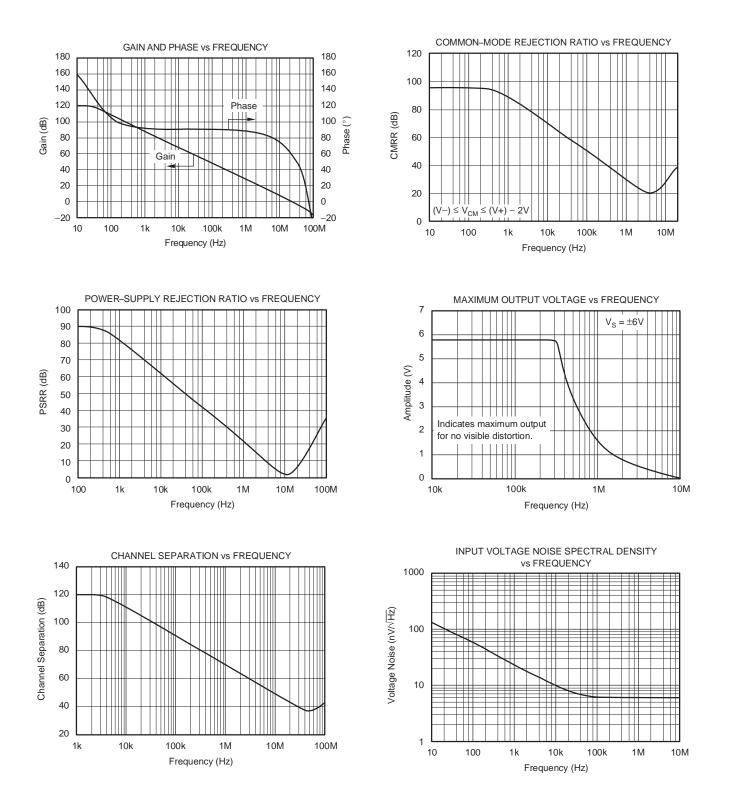
			OPA725, OPA			
PARAMETER		CONDITIONS	MIN	TYP	MAX	UNIT
OUTPUT						
Voltage Output Swing from Rail						
OPA725, OPA726		$R_L = 100 k\Omega$ , $A_{OL} > 110 dB$		100	150	mV
Over Temperature		R <sub>L</sub> = 100kΩ, A <sub>OL</sub> > 100dB			150	mV
OPA2725, OPA2726		$R_L = 100 k\Omega$ , $A_{OL} > 110 dB$		125	175	mV
Over Temperature		R <sub>L</sub> = 100kΩ, A <sub>OL</sub> > 100dB			175	mV
OPA725, OPA726		$R_L = 1k\Omega$ , $A_{OL} > 106dB$		200	250	mV
Over Temperature		R <sub>L</sub> = 1kΩ, A <sub>OL</sub> > 96dB			250	mV
OPA2725, OPA2726		$R_L = 2k\Omega$ , $A_{OL} > 106dB$		200	250	mV
Over Temperature		R <sub>L</sub> = 2kΩ, A <sub>OL</sub> > 96dB			250	mV
Output Current	IOUT	V <sub>S</sub> – V <sub>OUT</sub>  < 1V		40		mA
Short-Circuit Current	I <sub>SC</sub>			±55		mA
Capacitive Load Drive	CLOAD		See Ty	pical Charac	teristics	
Open-Loop Output Impedance		$f = 1 MHz, I_0 = 0$		40		Ω
ENABLE/SHUTDOWN (OPAx726)						
t <sub>OFF</sub>				5		μs
t <sub>ON</sub>				30		μs
Enable Reference (DGND) Voltage Range	V <sub>DGND</sub>		V–		(V+) – 2	V
V <sub>L</sub> (shutdown)					< V <sub>DGND</sub> +0.8V	V
V <sub>H</sub> (amplifier is active)			> V <sub>DGND</sub> +2V			V
Input Disable Current		Ref Pin = Enable Pin = V-		5		μΑ
I <sub>QSD</sub> (per amplifier)				6	15	μΑ
POWER SUPPLY						
Specified Voltage Range	VS		4		12	V
Operating Voltage Range	VS			3.5 to 13.2		V
Quiescent Current (per amplifier)	lq	I <sub>O</sub> = 0		4.3	5.5	mA
Over Temperature					6	mA
TEMPERATURE RANGE						
Specified Range			-40		125	°C
Operating Range			-55		125	°C
Storage Range			-55		150	°C
Thermal Resistance	$\theta_{JA}$					
SOT23-5				200		°C/W
MSOP-8, MSOP-10, SO-8				150		°C/W

SBOS278B - SEPTEMBER 2003 - REVISED JANUARY 2004



#### **TYPICAL CHARACTERISTICS**

At  $T_A = +25^{\circ}C$ ,  $V_S = \pm 6V$ ,  $R_L = 10k\Omega$  connected to  $V_S/2$ , and  $V_{OUT} = V_S/2$ , unless otherwise noted.

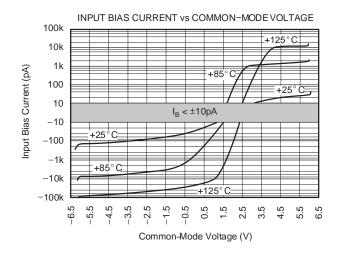


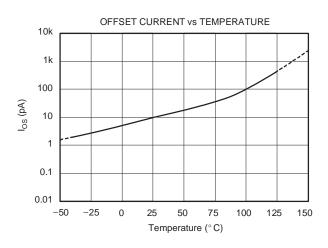
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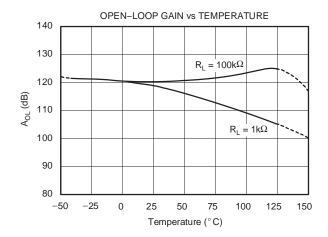
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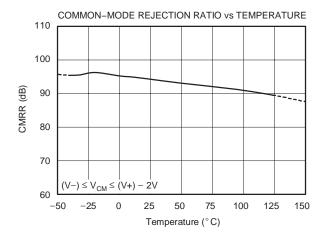
#### **TYPICAL CHARACTERISTICS (continued)**

At T<sub>A</sub> = +25°C, V<sub>S</sub> =  $\pm$ 6V, R<sub>L</sub> = 10k $\Omega$  connected to V<sub>S</sub>/2, and V<sub>OUT</sub> = V<sub>S</sub>/2, unless otherwise noted.

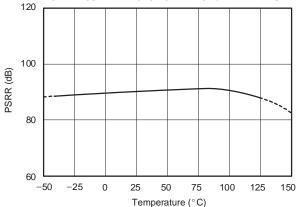


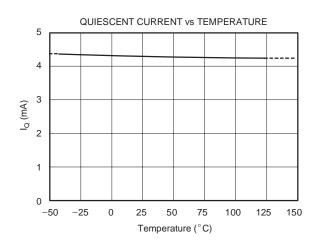






POWER-SUPPLY REJECTION RATIO vs TEMPERATURE



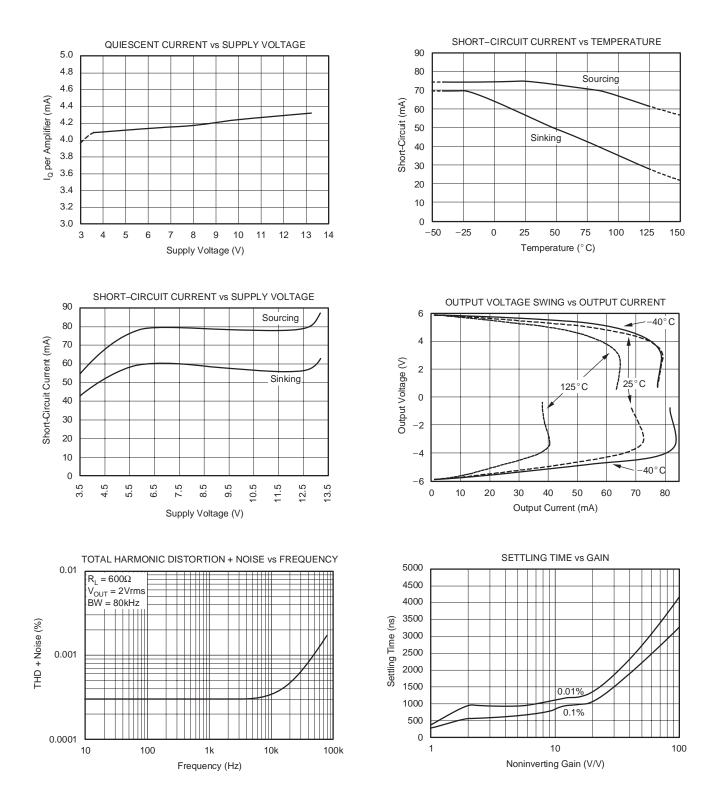


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#### **TYPICAL CHARACTERISTICS (continued)**

At T<sub>A</sub> = +25°C, V<sub>S</sub> = ±6V, R<sub>L</sub> = 10k $\Omega$  connected to V<sub>S</sub>/2, and V<sub>OUT</sub> = V<sub>S</sub>/2, unless otherwise noted.

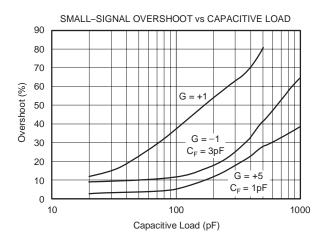




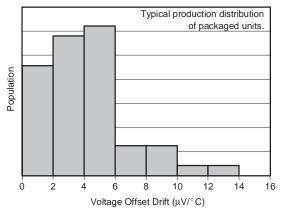
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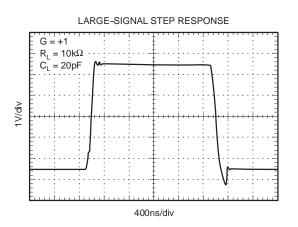
#### **TYPICAL CHARACTERISTICS (continued)**

At T<sub>A</sub> = +25°C, V<sub>S</sub> =  $\pm$ 6V, R<sub>L</sub> = 10k $\Omega$  connected to V<sub>S</sub>/2, and V<sub>OUT</sub> = V<sub>S</sub>/2, unless otherwise noted.

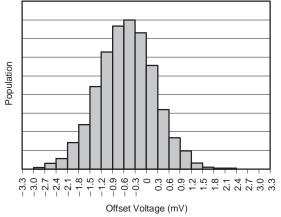


VOLTAGE OFFSET DRIFT PRODUCTION DISTRIBUTION

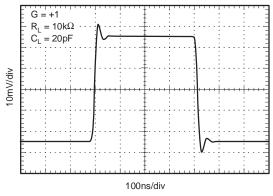




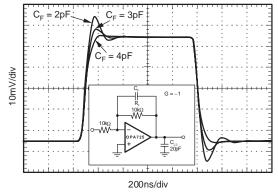
OFFSET VOLTAGE PRODUCTION DISTRIBUTION



SMALL-SIGNAL STEP RESPONSE



SMALL-SIGNAL STEP RESPONSE

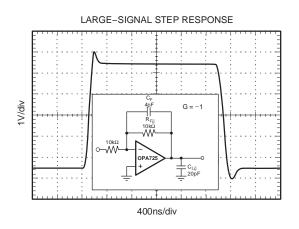


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#### **TYPICAL CHARACTERISTICS (continued)**

At T<sub>A</sub> = +25°C, V<sub>S</sub> = ±6V, R<sub>L</sub> = 10k $\Omega$  connected to V<sub>S</sub>/2, and V<sub>OUT</sub> = V<sub>S</sub>/2, unless otherwise noted.



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### OPA725, OPA2725 OPA726, OPA2726

**APPLICATIONS INFORMATION** 

OPA725 and OPA726 series 20MHz CMOS op amps have a fast slew rate, low noise, and excellent PSRR, CMRR, and  $A_{OL}$ . These op amps can operate on typically 4.3mA quiescent current from a single (or split) supply in the range of 4V to 12V ( $\pm$ 2V to  $\pm$ 6V), making them highly versatile and easy to use. They are stable in a unity-gain configuration.

Power-supply pins should be bypassed with 1nF ceramic capacitors in parallel with  $1\mu$ F tantalum capacitors.

#### **OPERATING VOLTAGE**

OPA725 series op amps are specified from 4V to 12V supplies over a temperature range of  $-40^{\circ}$ C to  $+125^{\circ}$ C. They will operate well in  $\pm$ 5V or +5V to +12V power-supply systems. Parameters that vary significantly with operating voltage or temperature are shown in the Typical Characteristics.

#### ENABLE/SHUTDOWN

OPA725 series op amps require approximately 4.3mA quiescent current. The enable/shutdown feature of the OPA726 allows the op amp to be shut off to reduce this current to approximately  $6\mu$ A.

The enable/shutdown input is referenced to the Enable Reference Pin, DGND (see Pin Configurations). This pin can be connected to logic ground in dual-supply op amp configurations to avoid level-shifting the enable logic signal, as shown in Figure 1.

The Enable Reference Pin voltage,  $V_{DGND}$ , must not exceed (V+) – 2V. It may be set as low as V–. The amplifier is enabled when the Enable Pin voltage is greater than  $V_{DGND}$  + 2V. The amplifier is disabled (shutdown) if the Enable Pin voltage is less than  $V_{DGND}$  + 0.8V. The Enable Pin is connected to internal pull-up circuitry and will enable the device if left unconnected.

#### **COMMON-MODE VOLTAGE RANGE**

The input common-mode voltage range of the OPA725 and OPA726 series extends from V- to (V+) - 2V.

Common-mode rejection is excellent throughout the input voltage range from V– to (V+) – 3V. CMRR decreases somewhat as the common-mode voltage extends to (V+) – 2V, but remains very good and is tested throughout this range. See the Electrical Characteristics table for details.

SBOS278B - SEPTEMBER 2003 - REVISED JANUARY 2004

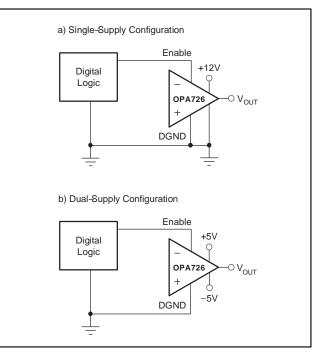


Figure 1. Enable Reference Pin Connection for Single- and Dual-Supply Configurations

#### INPUT OVER-VOLTAGE PROTECTION

Device inputs are protected by ESD diodes that will conduct if the input voltages exceed the power supplies by more than approximately 300mV. Momentary voltages greater than 300mV beyond the power supply can be tolerated if the current is limited to 10mA. This is easily accomplished with an input resistor in series with the op amp, as shown in Figure 2. The OPA725 series features no phase inversion when the inputs extend beyond supplies, if the input is current limited.

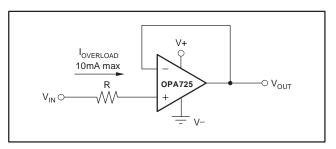


Figure 2. Input Current Protection for Voltages Exceeding the Supply Voltage

SBOS278B - SEPTEMBER 2003 - REVISED JANUARY 2004

#### **RAIL-TO-RAIL OUTPUT**

A class AB output stage with common-source transistors is used to achieve rail-to-rail output. This output stage is capable of driving heavy loads connected to any point between V+ and V-. For light resistive loads ( >  $100k\Omega$  ), the output voltage can swing to 150mV (175mV for dual) from the supply rail, while still maintaining excellent linearity ( $A_{OL}$  > 110dB). With  $1k\Omega$  ( $2k\Omega$  for dual) resistive loads, the output is specified to swing to within 250mV from the supply rails with excellent linearity (see the Typical Characteristics curve *Output Voltage Swing vs Output Current*).

#### CAPACITIVE LOAD AND STABILITY

Capacitive load drive is dependent upon gain and the overshoot requirements of the application. Increasing the gain enhances the ability of the amplifier to drive greater capacitive loads (see the Typical Characteristics curve *Small-Signal Overshoot vs Capacitive Load*).

One method of improving capacitive load drive in the unity-gain configuration is to insert a  $10\Omega$  to  $20\Omega$  resistor inside the feedback loop, as shown in Figure 3. This reduces ringing with large capacitive loads while maintaining DC accuracy.

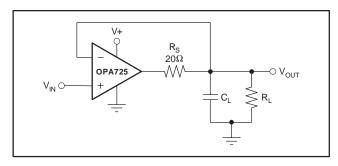
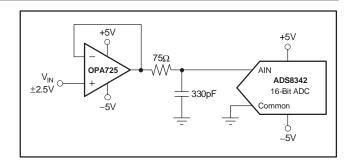


Figure 3. Series Resistor in Unity-Gain Buffer Configuration Improves Capacitive Load Drive

#### **DRIVING FAST 16-BIT ADCs**

The OPA725 series is optimized for driving fast 16-bit ADCs such as the ADS8342. The OPA725 op amps buffer the converter input capacitance and resulting charge injection, while providing signal gain. Figure 4 shows the OPA725 in a single-ended method of interfacing to the ADS8342 16-bit, 250kSPS, 4-channel ADC with an input range of ±2.5V. The OPA725 has demonstrated excellent settling time to the 16-bit level within the 600ns acquisition time of the ADS8342. The RC filter, shown in Figure 4, has been carefully tuned for best noise and settling performance. It may need to be adjusted for different op amp configurations. Please refer to the ADS8342 data sheet (available for download at www.ti.com) for additional information on this product.



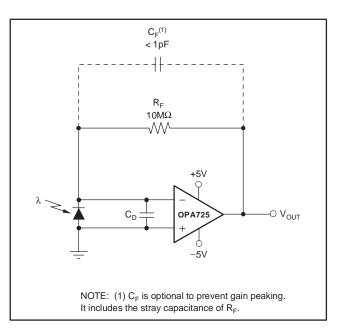




#### TRANSIMPEDANCE AMPLIFIER

Wide bandwidth, low input bias current, and low input voltage and current noise make the OPA725 an ideal wideband photodiode transimpedance amplifier. Low-voltage noise is important because photodiode capacitance causes the effective noise gain of the circuit to increase at high frequency.

The key elements to a transimpedance design, as shown in Figure 5, are the expected diode capacitance ( $C_D$ ), which should include the parasitic input common-mode and differential-mode input capacitance (4pF + 5pF for the OPA725); the desired transimpedance gain ( $R_F$ ); and the GBW for the OPA725 (20MHz). With these three variables set, the feedback capacitor value ( $C_F$ ) can be set to control the frequency response.  $C_F$  includes the stray capacitance of  $R_F$ , which is 0.2pF for a typical surface-mount resistor.







To achieve a maximally-flat, 2nd-order Butterworth frequency response, the feedback pole should be set to:

$$\frac{1}{2\pi R_F C_F} = \sqrt{\frac{GBW}{4\pi R_F C_D}}$$
(1)

Bandwidth is calculated by:

$$f_{-3dB} = \sqrt{\frac{GBW}{2\pi R_F C_D}} Hz$$
(2)

For even higher transimpedance bandwidth, the high-speed CMOS OPA354 (100MHz GBW), OPA300 (180 MHz GBW), OPA355 (200MHz GBW), or OPA656, OPA657 (400MHz GBW) may be used.

For single-supply applications, the +IN input can be biased with a positive dc voltage to allow the output to reach true zero when the photodiode is not exposed to any light, and respond without the added delay that results from coming out of the negative rail. (Refer to Figure 6.) This bias voltage also appears across the photodiode, providing a reverse bias for faster operation.

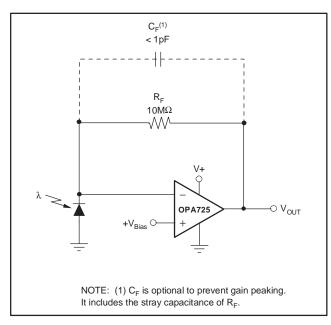


Figure 6. Single-Supply Transimpedance Amplifier

SBOS278B - SEPTEMBER 2003 - REVISED JANUARY 2004

For additional information, refer to Application Bulletin SBOA055, *Compensate Transimpedance Amplifiers Intuitively*, available for download at www.ti.com.

#### OPTIMIZING THE TRANSIMPEDANCE CIRCUIT

To achieve the best performance, components should be selected according to the following guidelines:

- For lowest noise, select R<sub>F</sub> to create the total required gain. Using a lower value for R<sub>F</sub> and adding gain after the transimpedance amplifier generally produces poorer noise performance. The noise produced by R<sub>F</sub> increases with the square-root of R<sub>F</sub>, whereas the signal increases linearly. Therefore, signal-to-noise ratio is improved when all the required gain is placed in the transimpedance stage.
- 2. Minimize photodiode capacitance and stray capacitance at the summing junction (inverting input). This capacitance causes the voltage noise of the op amp to be amplified (increasing amplification at high frequency). Using a low-noise voltage source to reverse-bias a photodiode can significantly reduce its capacitance. Smaller photodiodes have lower capacitance. Use optics to concentrate light on a small photodiode.
- Noise increases with increased bandwidth. Limit the circuit bandwidth to only that required. Use a capacitor across the R<sub>F</sub> to limit bandwidth, even if not required for stability.
- 4. Circuit board leakage can degrade the performance of an otherwise well-designed amplifier. Clean the circuit board carefully. A circuit board guard trace that encircles the summing junction and is driven at the same voltage can help control leakage.

For additional information, refer to the Application Bulletins Noise Analysis of FET Transimpedance Amplifiers (SBOA060), and Noise Analysis for High-Speed Op Amps (SBOA066), available for download at the TI web site.



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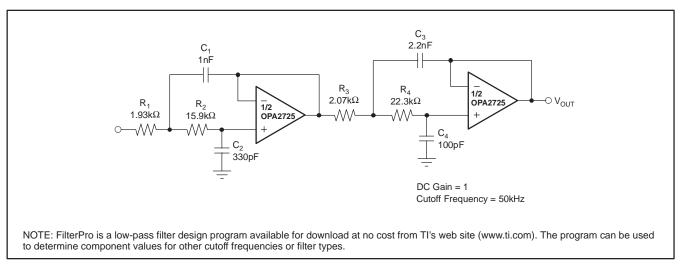


Figure 7. Four-Pole Butterworth Sallen-Key Low-Pass Filter



## PACKAGE OPTION ADDENDUM

4-Mar-2005

#### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finisl	n MSL Peak Temp <sup>(3)</sup>
OPA2725AID	ACTIVE	SOIC	D	8	100	None	CU NIPDAU	Level-3-240C-168 HR
OPA2725AIDGKR	ACTIVE	MSOP	DGK	8	2500	None	CU NIPDAU	Level-1-240C-UNLIM
OPA2725AIDGKT	ACTIVE	MSOP	DGK	8	250	None	CU NIPDAU	Level-1-240C-UNLIM
OPA2725AIDR	ACTIVE	SOIC	D	8	2500	None	CU NIPDAU	Level-3-240C-168 HR
OPA2726AIDGSR	ACTIVE	MSOP	DGS	10	2500	None	CU NIPDAU	Level-1-240C-UNLIM
OPA2726AIDGST	ACTIVE	MSOP	DGS	10	250	None	CU NIPDAU	Level-1-240C-UNLIM
OPA725AID	ACTIVE	SOIC	D	8	100	None	CU NIPDAU	Level-3-240C-168 HR
OPA725AIDBVR	ACTIVE	SOT-23	DBV	5	3000	None	CU NIPDAU	Level-1-240C-UNLIM
OPA725AIDBVT	ACTIVE	SOT-23	DBV	5	250	None	CU NIPDAU	Level-1-240C-UNLIM
OPA725AIDR	ACTIVE	SOIC	D	8	2500	None	CU NIPDAU	Level-3-240C-168 HR
OPA726AID	ACTIVE	SOIC	D	8	100	None	CU NIPDAU	Level-3-240C-168 HR
OPA726AIDGKR	ACTIVE	MSOP	DGK	8	2500	None	CU NIPDAU	Level-2-240C-1 YEAR
OPA726AIDGKT	ACTIVE	MSOP	DGK	8	250	None	CU NIPDAU	Level-2-240C-1 YEAR
OPA726AIDR	ACTIVE	SOIC	D	8	2500	None	CU NIPDAU	Level-3-240C-168 HR

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - May not be currently available - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

None: Not yet available Lead (Pb-Free).

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

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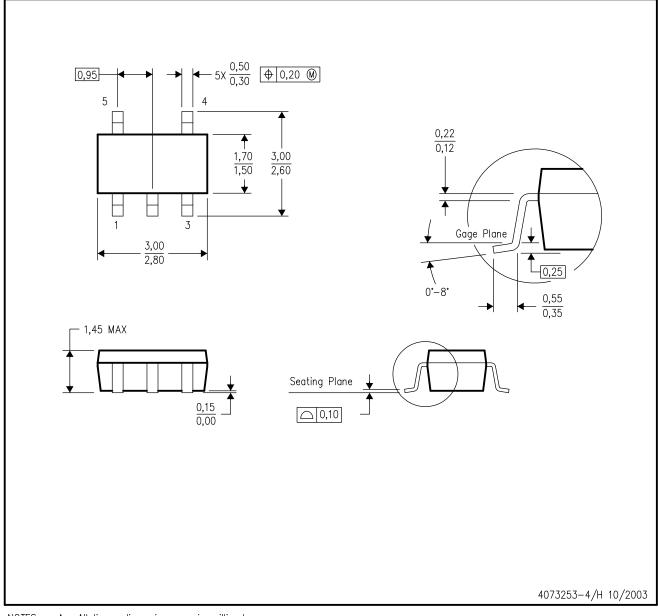
<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDECindustry standard classifications, and peak solder temperature.

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DBV (R-PDSO-G5)

## PLASTIC SMALL-OUTLINE PACKAGE



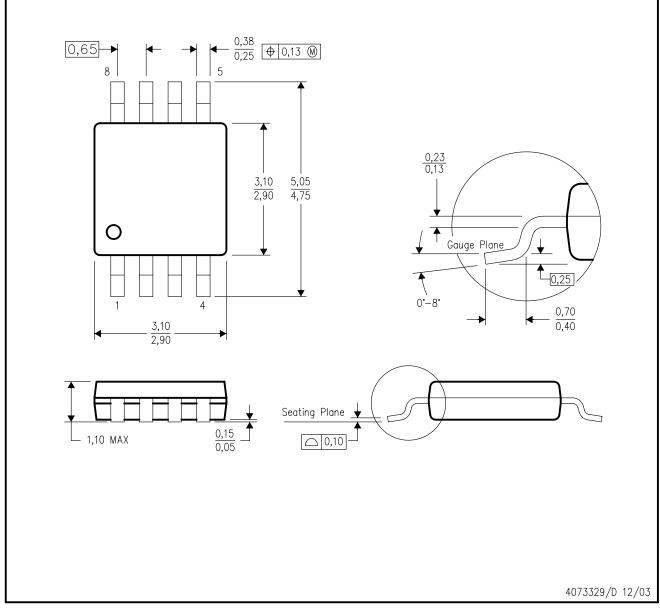
NOTES:

- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Body dimensions do not include mold flash or protrusion.
  - D. Falls within JEDEC MO-178 Variation AA.



DGK (S-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

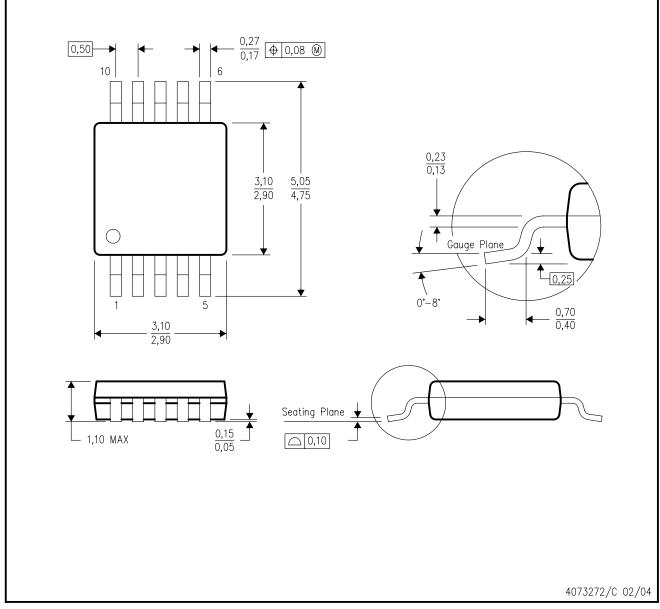
A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion.
- D. Falls within JEDEC MO-187 variation AA.



DGS (S-PDSO-G10)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

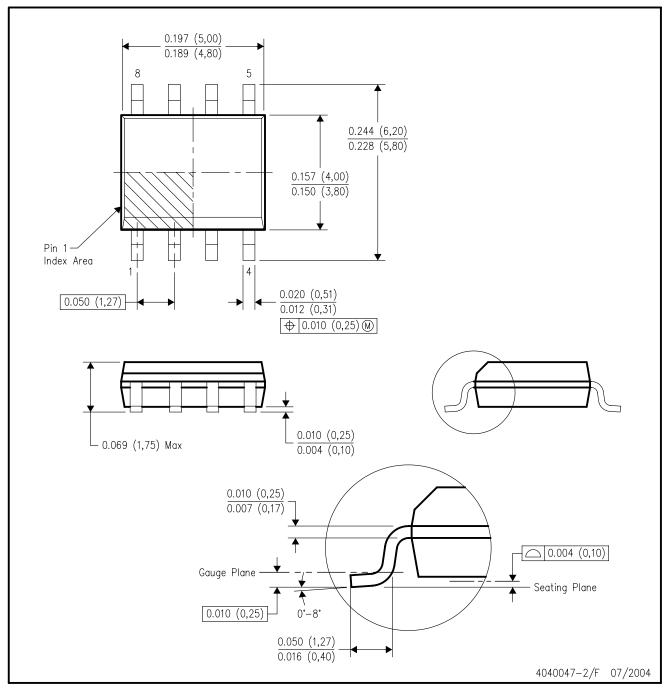
A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion.
- D. Falls within JEDEC MO-187 variation BA.



D (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-012 variation AA.



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